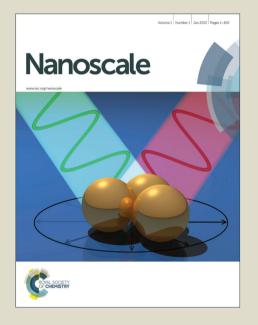
# Nanoscale

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# Confocal absorption spectral imaging of $MoS_2$ : optical transitions depending on the atomic thickness of intrinsic and chemically doped $MoS_2$

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Abstract: We performed a nanoscale confocal absorption spectral imaging to obtain the full absorption spectra (over the range 1.5- 3.2 eV) within regions of having different numbers of layers and studied the variation of optical transition depending on the atomic thickness of MoS<sub>2</sub> film. Three distinct absorption bands corresponding to A and B excitons and a high-energy background (BG) peak at 2.84 eV displayed a gradual redshift as the MoS<sub>2</sub> film thickness increased from monolayer, to bilayer, to bulk MoS<sub>2</sub> and this shift was attributed to the reduction of the gap energy in the Brillouin zone at the K-point as the atomic thickness increased. We also performed n-type chemical doping of MoS<sub>2</sub> films using reduced benzyl viologen (BV) and the confocal absorption spectra modified by the doping showed a strong dependence on atomic thickness: A and B exciton peaks were greatly quenched in monolayer MoS<sub>2</sub> while much less effect was shown in larger thickness and BG peak either showed very small quenching for 1 L MoS<sub>2</sub> or remained constant for larger thicknesses. Our results indicate that confocal absorption spectral imaging can provide comprehensive information on optical transitions of microscopic size intrinsic and doped two-dimensional layered materials.

Molybdenum disulfide (MoS<sub>2</sub>) is an emerging two-dimensional layered material that undergoes a

### Introduction

distinct transition from a structure that features an indirect bandgap to a structure that features a direct bandgap as the material thinned down to a monolayer which suggest promising optoelectronic applications. 1-6 Optical experimental studies of MoS2 have reported distinct photo luminescence (PL) bands around at 1.9 eV which were attributed to bandgap transition in the K-point of the Brillouin zone. 1,5,7 Studies have also showed that the valence band (VB) is split at the K-point, due to spin-orbit coupling (SOC) (in the monolayer) and also the interlayer interaction energy (in multi-layers) which produces two separate exciton bands, the A and B excitons. 1,5,6 Experimental absorption spectra have showed the A and B exciton transitions at the same energy positions observed in PL measurements. 1,4,8 However, some recent theoretical studies of the band structure and optical transition spectra of MoS<sub>2</sub>have suggested that monolayer MoS<sub>2</sub> possesses much larger bandgap and exciton binding energy as well as the existence of additional absorption peak around at 2.8 eV. 9-14 For example, Cheiwchanchamnangij et al. used the quasiparticle self-consistent GW method which resulted in  $\sim 2.75$ eV bandgap of monolayer MoS<sub>2</sub><sup>9</sup>, and Molina-S'anchez et al. and Qiu et al. independently reported the presence of additional high-energy exciton peaks beyond 2.4 eV in the calculated optical spectra using the Bethe-Salpeter equation. 10,11 The time decay and low temperature dependence of the MoS<sub>2</sub> PL excitons were studied, revealing a very fast decay rate of a few ps. 15 Zhang et al. 16 reported the use of scanning tunneling spectroscopy and measured a 220 meV exciton binding energy in monolayer MoS<sub>2</sub>, much lower than the value predicted by most theoretical calculations. 9-13

The band structures of  $MoS_2$ , particularly the band gap energy at K-point and the exciton energy level, have not been elucidated, even though extensive theoretical and experimental studies have been applied toward these aims. The optical absorption spectra of  $MoS_2$  films beyond 2.4 eV can provide critical information about the band structures of  $MoS_2$  and their evolution as a function of the atomic

thickness: monolayer, bi-layer, and bulk. Previous reports of optical spectra of the  $MoS_2$  films beyond 2.4 eV lack detailed interpretation about the high-energy absorption peaks and the layer dependence of these peaks were never addressed. Recently, photoluminescence excitation measurements of mono- and bilayer  $MoS_2$  were conducted. The absorption peak at ~2.8 eV was attributed to a transition among the nesting bands between the  $\Gamma$  and  $\Lambda$  positions of the Brillouin zone.  $^{21,22}$ 

Doping of two-dimensional transition metal dichalcogenide (TMD) materials exhibits intriguing electronic, optical, structural, and chemical properties that are potentially useful in many optoelectronic devices. 23-28 Monolayer MoS<sub>2</sub> film was doped in various ways by applying gate bias voltage to the MoS<sub>2</sub>FET devices, by using physisorption gas molecules and by using chemical solution. 23-26,28 Chemical doping to the MoS<sub>2</sub> has received the special attention, because this way of doping was shown to achieve n-type doping to degenerate level for few layer MoS2 and WS2 using alkali metal vapor (K vapour), <sup>26</sup> however alkali metals are not stable in ambient environment which limits their practical applications. Reduced benzyl viologen (BV) possesses high reduction potential values and regarded as an excellent air stable n-type dopant of the two-dimensional materials. 28-30 Modification of PL and absorption spectra of the doped monolayer MoS<sub>2</sub> showed the formation of the tightly bounded trion at high electron concentrations. <sup>23,24</sup> All these optical studies of doped MoS<sub>2</sub> were performed within the spectral range 1.7- 2.2 eV, mainly focusing on A and B exciton PL and absorption peaks. Previously, optical spectra of the doped graphene and two-dimensional semiconductor systems were studied and the quenching or enhancement and the spectral shift of PL or absorption peaks were observed.  $^{23,31-34}$  However, so far no study of optical absorption spectra of the chemically doped  $MoS_2$ film was reported.

We employed the solution based chemical doping using the BV to the various atomic thicknesses of MoS<sub>2</sub> films to achieve the n-type doping effect. BV has been used as an efficient n-type dopant to the CNT and graphene<sup>29,30</sup> and recently was demonstrated on the trilayer MoS<sub>2</sub> film.<sup>28</sup> Here,we investigated the doping effect on PL, absorption and Raman spectra of MoS<sub>2</sub> films with different atomic thicknesses. Optical absorption spectral measurements in two-dimensional materials usually

require large-area samples and suffer from the low signal of the differential reflectance if used on microscopic sized samples, thereby hindering the systematic study of optical transitions in MoS<sub>2</sub> samples having different atomic thickness. Recently, confocal absorption mapping techniques revealed the anisotropic absorption properties of organic single rubrene nanoplates and Au/rubrene hybrid nanofibers.<sup>35,36</sup> Here we describe the absorption spectra of intrinsic and doped MoS<sub>2</sub> thin films having different atomic thicknesses over the range from 1.5 - 3.2 eV using confocal absorption spectral mapping techniques combined with correlated PL, Raman, and AFM measurements.<sup>35</sup> The three distinct absorption bands obtained from each intrinsic and chemically doped MoS<sub>2</sub>film revealed the systematic variations of the peak position and the intensity as the film thickness increases from monolayer, to bilayer, to bulk.

### **Experimental**

Commercial natural 2H-MoS<sub>2</sub> crystals (2D Semiconductor Supplies Corp.) were mechanically cleaved using the scotch tape method and were deposited onto clean transparent slide glass of 1 mm thickness. Apparently thinner regions were located using an optical microscope and then exact film thicknesses were confirmed by the subsequent PL and Raman spectral imaging studies and the AFM imaging results obtained in the same region. The diameter of the illumination volume at the focus for PL and Raman measurements was around 300 nm. Scattered light was collected through the objective used for illumination and was guided to a 30 cm-long monochromator (equipped with a cooled CCD) through an optical fiber with a 50 µm core diameter, which acted as a confocal detection pinhole. Diffraction gratings with 150 grooves/mm and 1200 grooves/mm were used to collect the PL and Raman spectra, respectively. The 514, 488 and 458 nm lines of an Ar ion laser were used at intensities of less than 500 µW in a lab-made laser confocal microscope system equipped with a 0.95 NA objective lens. With this power level of laser illumination, no physical damage or oxidation is expected to occur on the MoS<sub>2</sub> films.<sup>37</sup> Confocal absorption spectral imaging was used to obtain the local spectra at each scanning pixel position. A schematic diagram of the confocal system used to obtain the correlated spectroscopic

measurements of the PL, Raman, and absorption spectra is shown in ESI (Figure S1).

We purchased positively charged 1,1'-dibenzyl-4,4'-bipyridinium dichloride (BV $^{2+}$ ) (Fluka Chemical Corp.) and reduced into the neutral benzyl BV using sodium borohydride following the known procedure. $^{29,30}$  Solution-based chemical doping was performed using a drop-cast method. The concentration of the BV in toluene solution was 5 mM. An approximately 10  $\mu$ L droplet of the solution was dispensed using a pipette directly on the sample where the flakes of different thicknesses of MoS $_2$  films were prepared. All optical measurements were performed after evaporating the solvent in ambient condition.

### **Results and discussion**

# Correlated PL and Raman spectral mapping of the MoS<sub>2</sub> films

Figure 1 shows the PL and Raman mapping images of a single area of the exfoliated MoS<sub>2</sub> films. This area contained MoS<sub>2</sub> films having a variety of thicknesses, as shown in the optical photograph inset of Figure 1(b). This area divided into two regions to collect the absorption, PL, and Raman spectra. The boundaries of these regions are indicated with white dotted lines. Figure 1(a) shows the PL intensity-integrated map, and the averaged PL spectra obtained from each region are plotted in Figure 1(b). The direct bandgap of the monolayer MoS<sub>2</sub> produced the strongest PL in this sample. The PL intensity decreased with increasing atomic thickness due to the direct-to-indirect bandgap transition. The average PL spectra obtained from each film thickness region displayed this trend, as shown in Figure 1(b). Two exciton PL peaks at 1.83 eV and 1.98 eV originated from the transition in the K-point of the Brilliouin zone.<sup>1,7</sup>

Figure 1(c) shows the Raman frequency map, and the averaged Raman spectra obtained from each region are plotted in Figure 1(d). The  $MoS_2$  films showed Raman band positions that depended on the layer number and could be used to identify the  $MoS_2$  layer number. 1,7,19,37-40 Consistent peak positions and a shift in the in-plane ( $E_{2g}^1$ ) and out-of-plane ( $A_{1g}$ ) Raman modes of the vibrations in each  $MoS_2$ 

were observed.<sup>1,37-40</sup> The wavenumber difference between the  $E_{2g}^1$  and  $A_{1g}$  peaks in the Raman spectra have frequently been used to identify the number of MoS<sub>2</sub> layers because these values change with the layer number.<sup>37-40</sup> The PL, Raman, and AFM measurements (ESI, Figure S2) were used here to identify monolayer (1L), bilayer (2L), trilayer (3L), quadruple-layer (4L), and few-layer (FL) regions, as noted in each mapping image. The maps of the  $A_{1g}$  Raman band position are displayed in Figure 1(c) which shows a gradual blue shift in the  $A_{1g}$  peak from 404 cm<sup>-1</sup> to 408 cm<sup>-1</sup> with increasing film thicknesses. The contrast appeared in the Raman mapping image is in a very good agreement with the original assignment of layer number. The average Raman spectra obtained from each layer also displayed this trend, as shown in Figure 3(d).

### Confocal absorption spectral imaging of MoS<sub>2</sub>

Figure 2 shows the absorption spectral maps obtained from the regions that had been mapped using PL and Raman spectroscopy. The absorption spectral mappings were carried out using confocal spectral mapping techniques<sup>23</sup> in the reflection mode and covered the spectral range 1.5–3.2 eV. The reflections of the thin absorbing film prepared on a glass substrate are directly proportional to the absorption properties of the film, according to the following relation, <sup>41,42</sup>

$$\frac{\Delta R}{R} = \frac{4}{n_c^2 - 1} \alpha(\lambda) n \tag{1}$$

Where,  $R,\alpha, n, n_s$  represent the measured reflectance, absorption coefficient, refractive index of the film, and refractive index of the substrate respectively. We assumed that n and  $n_s$  to be constant and wavelength-independent for the spectral range investigated. (See the Figure S9 in ESI for the comparison of absorption spectra with and without considering the dispersion of refractive index of the glass substrate.) Thus, experimentally measured  $\Delta R/R$  was directly proportional to the  $\alpha$  and thus, the differential reflection spectra obtained from different atomic thickness regions were regarded as the measure of the absorption spectra. All the absorption spectra were collected under identical illumination intensities and exposure times. The total integrated absorption intensity mappings of the

same sample regions are displayed in Figure 2(a). The regions identified as having different atomic thicknesses are indicated. These regions displayed uniform absorption strength throughout, except at the boundaries between regions having different thicknesses due to the finite ( $\sim$ 1  $\mu$ m) spatial resolution of the confocal absorption mapping. The absorption intensity increased with the atomic thickness. Interestingly, the absorption strength of 2L was almost exactly twice that of 1L; however, this proportionality constant did not hold beyond 3L.

Figure 2(b) we shows representative absorption spectra obtained from each layer region. The spectra were enlarged by certain factors and given offsets to facilitate a comparison. Three main features appeared in the absorption spectrum as A and B exciton peaks embedded in a continuous spectrum, with a maximum peak near 2.84 eV in the monolayer MoS<sub>2</sub>. The 1L region provided 1.88 eV and 2.03 eV peaks for the A and B exciton positions, similar to the values observed in the PL spectra in Figure 1. The splitting energy between the A and B peaks amounted to 0.15 eV in the monolayer and increased with increasing MoS<sub>2</sub>film thickness, reaching 0.16 eV in the bilayer and 0.19 eV in the bulk. This splitting caused by the splitting in VB is mostly due to SOC and some interlayer coupling present in multilayer MoS<sub>2</sub> film. <sup>1,9</sup> This trend of increasing splitting energy was also observed in APRES study on MoSe<sub>2</sub> <sup>43</sup> and the theoretical calculations for MoS<sub>2</sub> are summarized in Table 1. Interestingly, only the A exciton band displayed a clear redshift with increasing thickness, discussed further below.

### Evolution of the high-energy absorption peak depending on the atomic thickness of MoS<sub>2</sub>

A high-energy absorption peak was observed at 2.84 eV in the monolayer, consistent with recent experimental studies<sup>20</sup> and theoretical calculations.<sup>10,11,21</sup> This large background (BG) peak in the absorption spectrum may be understood as a broadening of the high-energy exciton peaks due to phonon–electron coupling.<sup>11</sup> We note that the peak position of this BG absorption peak decreased in energy and the spectral width increased with the film thickness. The peak position of this BG absorption band was closely related to the film thickness, as observed in the mapping images of the BG absorption band, as shown in Figure 2(c) and, interestingly, very close to the bandedge energy at K

point predicted in a theoretical study. <sup>11</sup> Each region having a different  $MoS_2$  film thickness cooverlapped with the peak position distribution of the BG absorption band. The high energy absorption peaks have been observed in previous experimental studies of  $MoS_2$ ; however, the origin of these peaks has not been discussed in detail, and the dependence of on the film thickness has not been evaluated. <sup>17, 19, 20</sup>

The observed absorption spectra and their dependence on the atomic thickness were modeled using a simple band transition scheme to describe the mono-, bi-, and bulk MoS<sub>2</sub> regions, as shown in Figure 3. The top of the valence band at the K-point was used as a reference in this diagram. It should be noticed that the shift of A exciton peak is originated from the change of exciton binding energy or the gap between the lowest conduction band (CB) and the highest valence band at K-point or a combination of both effects. The B-exciton position did not change significantly because the reduction in the exciton level was offset by an increase in the VB splitting.

A 458 nm wavelength (2.70 eV) laser was used to conduct the PL measurements at the on-resonance excitation of the BG absorption peak. The indirect PL observed under these conditions was much stronger than the PL intensity observed using 514 nm excitation. Figures 4(a) and 4(b) show the results of the PL mapping study, obtained in this new area using 514 nm (2.41 eV) and 458 nm (2.70 eV) laser excitation, respectively. The peak height of the A exciton band was normalized to reveal a factor of 4.5 increase in the indirect band PL of the bilayer MoS<sub>2</sub> when excited with 2.70 eV (compared to excitation at 2.41 eV). We attribute this increase in the indirect PL band to the relaxation of a larger number of generated carriers to the neighboring indirect band CB valley located between the K- and Γ-point the Brillouin zone.

We observed that the BG absorption peak at 2.84 eV in 1L MoS<sub>2</sub> shifted gradually as the MoS<sub>2</sub> thickness increased, reaching saturation at 2.61 eV in the bulk MoS<sub>2</sub>. It is interesting to see our thickness-dependent shift in the BG peak correlated to the shift predicted theoretically based on bilayer and bulk MoS<sub>2</sub> models, which found that the gap at the K-point decreased with increasing thickness.<sup>10</sup> The gap reductions of -0.09 eV and -0.18 eV for the bilayer and bulk, respectively, are similar to our

observations of the BG peak shifts of 0.09 eV and 0.23 eV, even though this work predicted the bandgap to be 2.2 eV, substantially smaller than the observed BG absorption peaks. Further experiments are required to prove whether this similarity is originated from that BG peak represents the bandedge energy in K-point or just a coincidental appearance.

### Doping effect on the optical properties of the MoS<sub>2</sub>

Figure 5 displays the PL and Raman result of the chemically doped MoS<sub>2</sub> films using BV. This area (the same area shown in the optical photograph of the inset of Figure 4(a)) contained MoS<sub>2</sub> films having different atomic thicknesses. Figure 5(a) shows the PL intensity-integrated map, and the averaged PL spectra obtained from each thickness region before and after the doping by BV. The clear quenching and the redshift of the A exciton peak from PL spectra of 1L, 2L and 4L layer MoS<sub>2</sub> films are observed as effects of the doping as shown in the Figure 5(a). We observed a significant reduction and the red shift by 12 nm of the A exciton PL peak in the case of 1L MoS2, while these spectral modifications of PL on 2L and 4L are smaller. (See the ESI and Figure S6, S& and S8 for the decomposition of the PL peak into A, B and "trion" peaks and their variation in peak positions and the relative intensities with BV doping) This less effect of doping on thicker MoS<sub>2</sub> films could be because the BV adsorption mainly occurred on the topmost layer, which is similar to the case of chemically doped multi-layer graphenes. 44 The observed spectral modification of PL spectra as an effect of the BV doping are consistent with previous reports obtained with electrically doped 1 L MoS<sub>2</sub> film which are attributed to the quenching phenomena of the neutral exciton peak and the emergence of the trion peak, as the excess electrons are injected to the MoS<sub>2</sub> by the charge transfer phenomena of chemical doping. 23,24 These results showed that our BV treatment successfully performed the n-type doping of the mono- and multi layer MoS<sub>2</sub> films.

Figure 5(b) shows the map of  $A_{1g}$  Raman band position and the average Raman spectra obtained from each thickness region before (black curve) and after (red curve) the BV chemical doping. Raman spectra of CNT, graphene and MoS<sub>2</sub> have been used to diagnosis the doping level, because vibrational

energy is renormalized due to the electron-phonon interaction. 25,28-30,45,46 Observed thickness dependent shift of  $A_{1g}$  and  $E_{2g}^{1}$  Raman bands are consistent to the previously reported results. <sup>1,7,19,37</sup> As shown in the Figure 5(b), Raman spectra of the BV doped MoS<sub>2</sub> films taken from 1L, 2L and 4L thicknesses showed the softening of the A<sub>1g</sub> Raman band by 4.5 cm<sup>-1</sup> for 1L and 2.6 cm<sup>-1</sup> for 2L and the softening was negligible for the 4L case. The shift of the  $E_{2g}^1$  Raman band position was much less affected by the doping, where the shift was only 0.82 cm<sup>-1</sup> in 1L MoS<sub>2</sub> and less in 2L and 4L MoS<sub>2</sub>. This is due to the stronger electron phonon coupling of the  $A_{1g}$  mode than  $E_{2g}^1$  mode as the MoS<sub>2</sub> films are doped into n-type. 25,28 This thickness dependence of Raman band softening owing to the BV adsorption suggests again that the adsorption of BV molecules mainly occurred on the topmost layer of multilayer samples. However we cannot exclude the possibility that the BV adsorption property of MoS<sub>2</sub> may change with the film thickness. Either case Raman spectra obtained before and after the BV doping of MoS<sub>2</sub> films confirmed that adsorption of BV molecules on the surface of the 1L and multi layer MoS<sub>2</sub> films (See ESI Figure S5 for FT-IR signature of BV adsorption on MoS2 surface) effectively doped  $MoS_2$  films. We compare the level of our doped 1L  $MoS_2$  with the amount of the  $A_{1g}$  band shift in the Raman spectra. According to Chakraborty et al.25, softening of the A<sub>1g</sub> band by 4 cm<sup>-1</sup> corresponded to 1.8  $\times$  10<sup>13</sup> cm<sup>-2</sup> electron sheet density for the monolayer MoS<sub>2</sub>. This suggests that observed 4.5 cm<sup>-2</sup>  $^{1}$ decrease of  $A_{1g}$  Raman band with 5 mM BV solution must have provided the similar doping level which is the same order of the electron sheet density of degenerately doped level of a few layer MoS<sub>2</sub>  $(1.0 \times 10^{13} \text{cm}^{-2})$  achieved with K vapour. <sup>26</sup> This observation shows that chemical doping by BV is an efficient way of n-type doping for the 1L and multi layer MoS<sub>2</sub> and also suggests that it may be applied for the tuning of electronic structures of other two-dimensional TMD materials.

Figure 6 shows the absorption spectra of different atomic thickness (1L, 2L and 4L) MoS<sub>2</sub> films before and after chemical doping by BV. Our observation showed the strong quenching of A and B exciton absorption peaks for 1L MoS<sub>2</sub> and less effect for the thicker films. Small amount of the redshift

(~30 meV) in the A exciton band was also observed for 1L MoS<sub>2</sub> as highlighted in the Figure 6(b). Recent studies of optical absorption spectra with the gate voltage applied to the monolayer MoS<sub>2</sub> have also showed the reductions and the redshift of the A and B exciton absorption peaks.<sup>23</sup> The effects of chemical doping on the absorption spectra of different atomic thickness of MoS<sub>2</sub> are demonstrated here the first time. We note that BG absorption peak shows much less effect on the absorption intensity and the peak position, and virtually remains constant in larger thickness of MoS<sub>2</sub>. This suggests that nature of the BG peak is different from the A and B exciton peaks. The recent photocurrent study result of monolayer MoS<sub>2</sub>, which showed, under a lower bias voltage, A and B excitons were totally quenched while BG peak maintained its intensity, which was attributed to the unbound nature of the BG peak-corresponding exciton.<sup>47</sup> This report is in a good agreement with our observation, because unbound e-h pair is hardly influenced by the increase of excess carrier concentration.<sup>48,49</sup> Further experiments and analysis are required to fully understand the origin of the BG absorption peak.

### **Conclusions**

Full absorption spectra over the range 1.6–3.2 eV were obtained with submicron spatial resolution from intrinsic and chemically doped MoS<sub>2</sub> samples having different atomic thicknesses using confocal absorption spectral imaging. In addition to the characteristic A and B exciton bands observed at 1.88 and 2.03 eV, strong background absorption peaks were observed at 2.84 eV for the monolayer MoS<sub>2</sub> absorption spectra. All absorption peaks displayed gradual red shifts as the atomic thickness increased. The observed absorption spectra and their dependence on the atomic thickness were explained with a simple band scheme and were partially consistent with theoretical predictions and should help to understand the variations of the optical transitions of MoS<sub>2</sub> as a function of the atomic thickness. In addition, we studied the optical transitions of chemically doped MoS<sub>2</sub> using BV and observed that A and B absorption peaks quenched strongly for 1 L MoS<sub>2</sub> while BG absorption peak either showed very small quenching for 1 L MoS<sub>2</sub> or remained constant for larger thicknesses.

Table 1.

	Mono layer	Bilayer	Trilayer	Bulk
A exciton	1.88	1.86	1.83	1.82
B exciton	2.03	2.02	2.01	2.01
BG <sup>a</sup> peak	2.84	2.73	2.65	2.61
VBS <sup>b</sup> (exp.)	0.15	0.16	0.18	0.19
VBS <sup>b</sup> (ref.)	0.11 <sup>(c)</sup> , 0.10 <sup>(d)</sup>	0.16 <sup>(c)</sup>		0.23 <sup>(c)</sup>
BG shift	0	-0.11	-0.19	-0.23
$E_g$ (K-point) shift	0	-0.09 <sup>(c)</sup>		-0.18 <sup>(c)</sup>

a. Background, b. Valence band splitting energy, c. ref. 10 and d. ref.11

### **Notes and references**

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<sup>†</sup>Electronic Supplementary Information (ESI) available: Details about the confocal scanning spectral imaging system used to obtain the correlated PL, Raman, and absorption spectra and the atomic force microscopy (AFM) results are given. Additional absorption spectra obtained from the monolayer, bilayer, and bulk MoS<sub>2</sub> samples support the consistency of our measurements. Schematic of BV doping, Fourier transform infrared (FT-IR) spectra of MoS<sub>2</sub> films with and without BV doping, decomposition analysis of PL peak and the comparison of confocal absorption spectra with and without the compensation of the wavelength dispersion of the refractive index of the glass substrate are given.

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## **Figure Captions**

**Figure 1** PL and Raman spectral characterizations of the MoS<sub>2</sub> films obtained using 514 nm laser excitation. (a) PL mapping image, showing the integrated intensities of the A and B exciton peaks. The number of layers of MoS<sub>2</sub> films in the mapping area was determined based on the PL intensity, Raman peak positions and AFM measurement (b) The average PL spectra of the 1L, 2L, 3L, 4L, and FL MoS<sub>2</sub>. (c) Raman mapping image that shows the local A<sub>1g</sub> peak frequency positions. The peak position changes from 404 cm<sup>-1</sup> for the 1L to 408 cm<sup>-1</sup> for the FL region. (d) Average Raman spectra obtained from 1L, 2L, 3L, 4L, and FL MoS<sub>2</sub> regions. Lines along the peaks are guides for the eyes.

**Figure 2** (a) Absorption spectral mapping image showing the integrated absorption intensities. Each layer represented in the PL and Raman measurements was identified in the absorption mapping study. (b) The peak position mapping of the high-energy absorption peak. The 1L, 2L, and FL regions could be clearly resolved, suggesting that each film thickness provided a constant high-energy absorption peak position. (c) Averaged absorption spectra obtained from each layer. Spectra were normalized by the specified factor and were translated vertically to facilitate the comparison.

**Figure 3** Schematic diagram showing the optical transition at the K-point in the monolayer, bilayer, and bulk MoS<sub>2</sub> regions. The red shift in the A exciton peak originated from the lowering of the 1st exciton level. The B-exciton peak position did not change significantly because the reduction in the exciton level was offset by an increase in the valence band (VB) splitting energy. The background peak corresponds to the energy difference between the conduction band and the VB.

**Figure 4** (a) PL mapping results obtained using 514 nm (2.41 eV) laser excitation. The inset shows the optical microscopy image of the measured area. (b) PL mapping results obtained using 458 nm (2.70 eV) excitation. Note that the indirect PL band of the bilayer at 840 nm (1.48 eV) was much stronger than the intensity obtained using 2.41 eV excitation. The inset shows a comparison of the

normalized PL spectra obtained from the two laser excitation wavelengths.

**Figure 5** PL and Raman spectral characterizations of the intrinsic and BV doped MoS<sub>2</sub> films. (a) PL mapping image shows the direct comparison of the PL integrated intensities of the A and B exciton peaks obtained from intrinsic and doped MoS<sub>2</sub> films of different thicknesses. Layer number dependent effect of chemical doping are also demonstrated on the average PL spectra of the 1L, 2L and 4Lwhere the dotted line guides the peak position shift occurred as a result of the doping. (b) Raman mapping image correlated with the A<sub>1g</sub> peak frequency. The softening of the A<sub>1g</sub> peak frequency as an effect of doping is noticed. Average Raman spectra from 1L, 2L and 4L demonstrate the direct comparison and layer number dependency of the intrinsic and doped MoS<sub>2</sub> films.

**Figure 6** Absorption spectra of intrinsic (black curve) and chemically doped (red curve) MoS<sub>2</sub> film obtained from the 1L, 2L and 4L.(a) A and B excitons in the monolayer are strongly quenched after doping while BG peak is much less quenched. (b) Some (~30 meV) redshift of A and B absorption bands are observed for 1 L MoS<sub>2</sub>. (c, d) Absorption spectra of intrinsic and chemically doped 2L and 4L MoS<sub>2</sub>. Less quenching of A and B peaks is observed with increasing thickness of MoS<sub>2</sub>. BG peak stays constant for 2L and 4L thickness layers.

### **Table Captions**

**Table 1**. Peak positions of the absorption bands of the A exciton, B exciton, and background (BG). The splitting energy between A and B excitons (VBS), observed here in comparison with the values reported previously, are shown. Also shown are the observed shift in the difference between the A exciton peak and the BG peak (BG shift), and the predicted shift of the band gap energy (E<sub>g</sub> shift) as a function of the sample thickness.

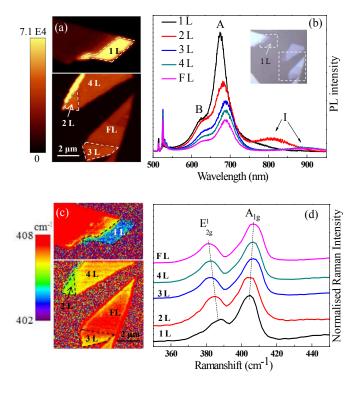


Fig. 1 Dhakal et al.

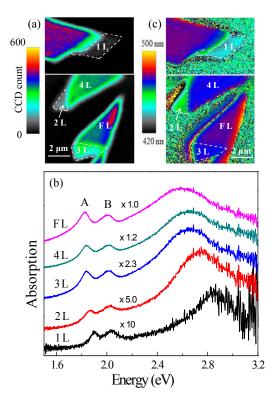


Fig. 2 Dhakal et al.

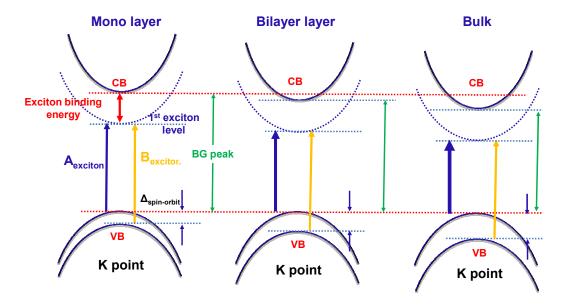


Fig. 3 Dhakal et al.

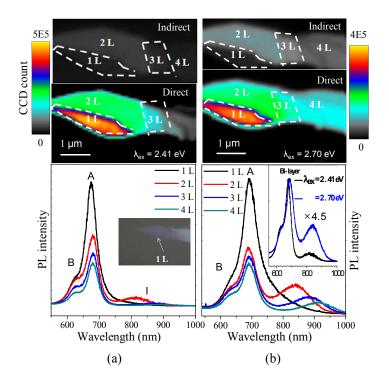


Fig. 4 Dhakal et al.

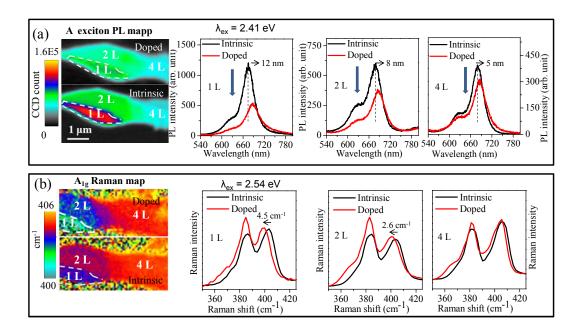


Fig. 5 Dhakal et al.

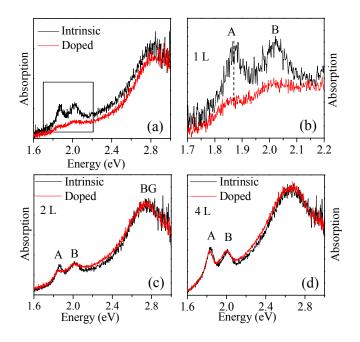


Fig. 6 Dhakal et al.